
EE4280 Lecture 9: Noise

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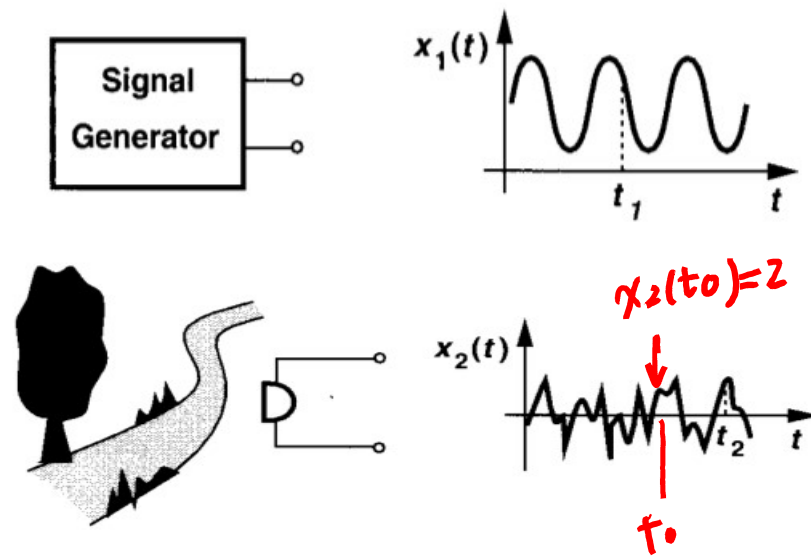
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What is Noise?

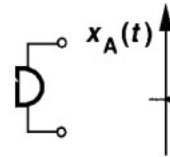
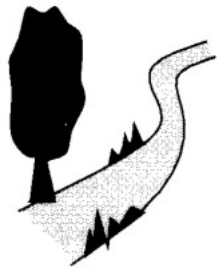
Noise is a random process. We consider a phenomenon random because we do not know everything about it, or simply because we do not need to know everything about it.



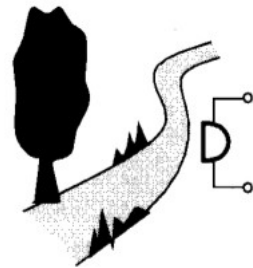
Since the instantaneous noise amplitude is not known, we resort to 'statistical' models, i.e., some properties that can be predicted.

Statistical Characterization

1. Mean and Average Power



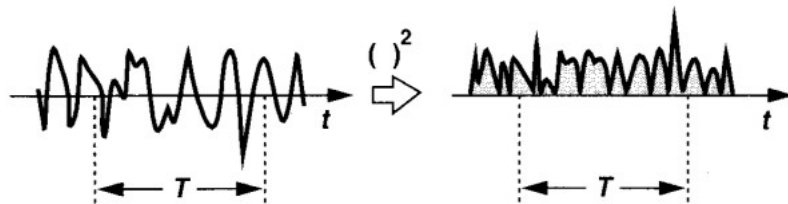
$$\lim_{T \rightarrow \infty} \frac{1}{T} \int_T x_A(t) dt = \overline{x_A} = 0$$



$$\lim_{T \rightarrow \infty} \frac{1}{T} \int_T x_A^2(t) dt = \overline{x_A^2} = 25 \mu V^2 = (5 \text{ mV}_{\text{rms}})^2$$

$$\overline{x_B^2} = (15 \text{ mV})^2$$

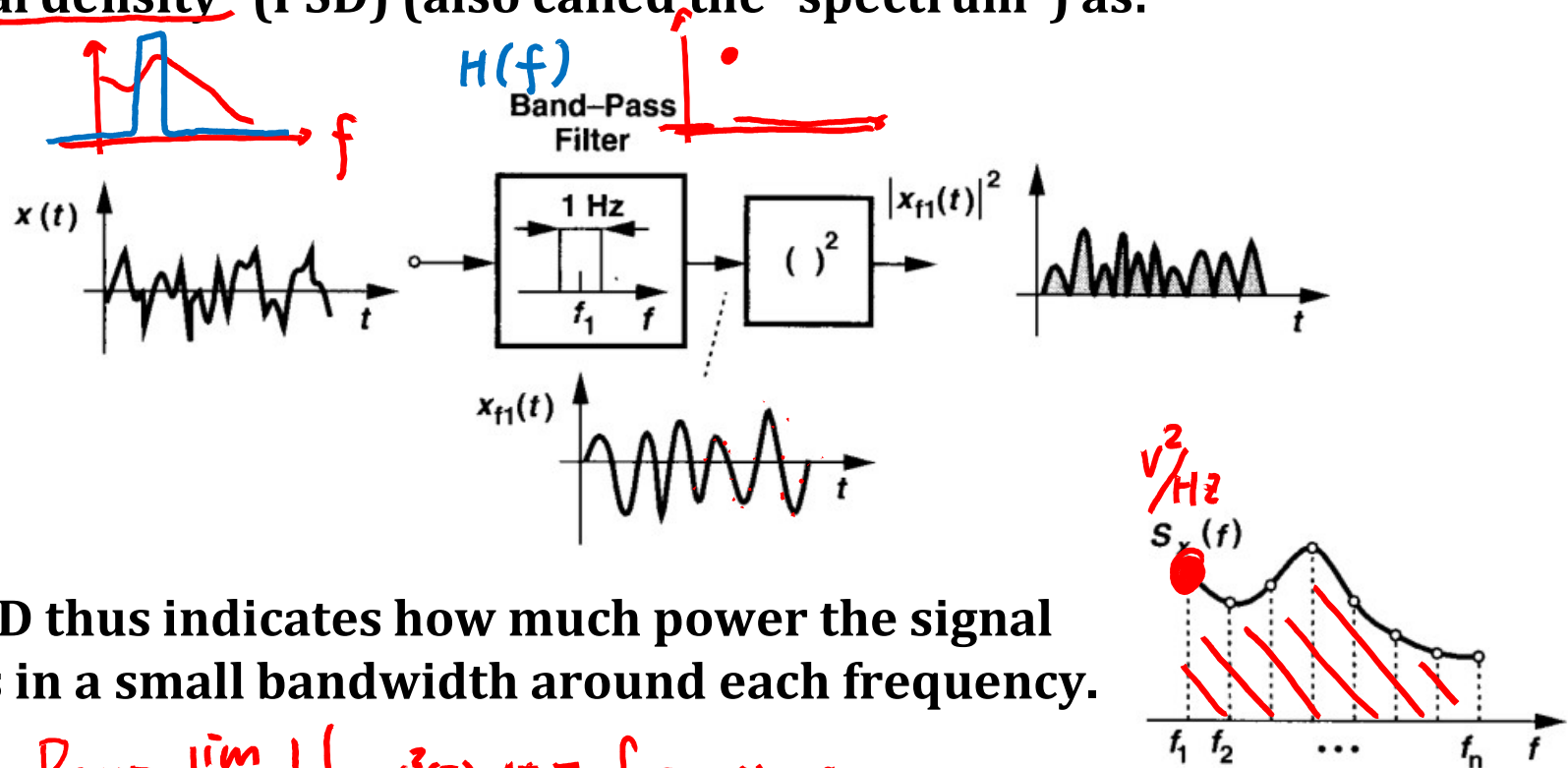
Larger fluctuations mean that the noise is 'stronger'



Statistical Characterization

2. Frequency Domain

For random signals, the concept of Fourier transform cannot be directly applied. But we still know that men carry less high-frequency components in their voice than women do. We define the “power spectral density” (PSD) (also called the “spectrum”) as:



The PSD thus indicates how much power the signal carries in a small bandwidth around each frequency.

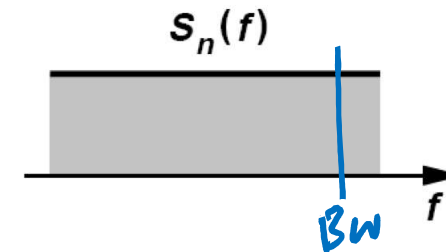
$$P_{av} = \lim_{T \rightarrow \infty} \frac{1}{T} \int_T x^2(\tau) d\tau = \int S_x(f) df$$

Statistical Characterization

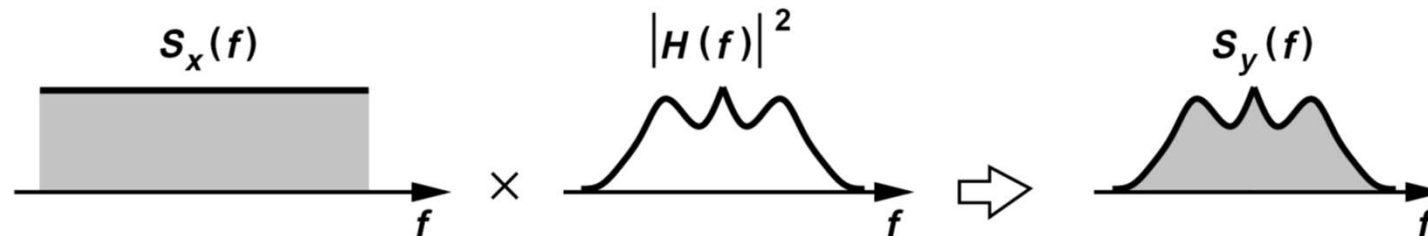
- What is the unit of $S_n(f)$?
- What is the total noise power?

A flat spectrum is called 'white'

- Is the total noise power infinite?



Important Theorem



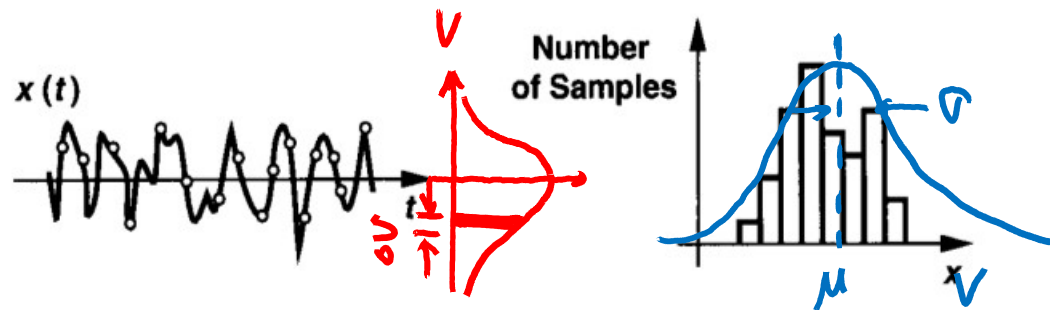
If a signal with spectrum $S_x(f)$ is applied to a linear time-invariant system with transfer function $H(s)$, the output spectrum is given by

$$S_Y(f) = S_X(f)|H(f)|^2$$

Statistical Characterization

3. Amplitude Distribution

By sampling the time-domain waveform for a long time, we can construct a “probability density function” (PDF). The PDF in essence indicates “how often” the amplitude is between certain limits.



For example, a Gaussian distribution is defined by a mean and a standard deviation. We say the noise amplitude rarely exceeds 4σ .

Note: Generally PDF and PSD bear no relationship.

Thermal Noise: Gaussian, white

Flicker Noise: Gaussian, not white

Correlated and Uncorrelated Sources

Can we use superposition for average noise power from a few noise components?

$$P_{av} = \lim_{T \rightarrow \infty} \frac{1}{T} \int_{-T/2}^{+T/2} [x_1(t) + x_2(t)]^2 dt$$

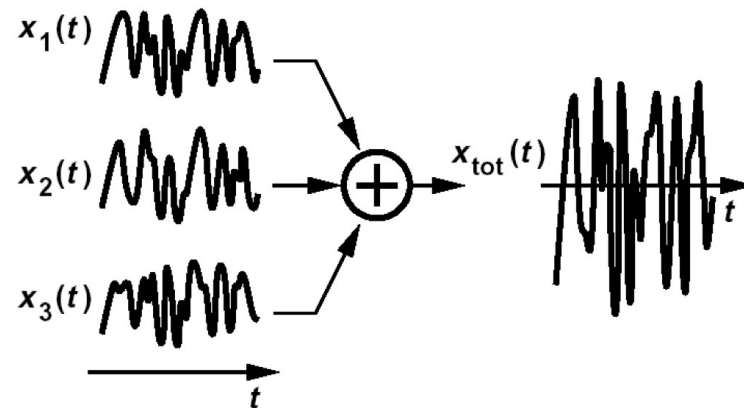
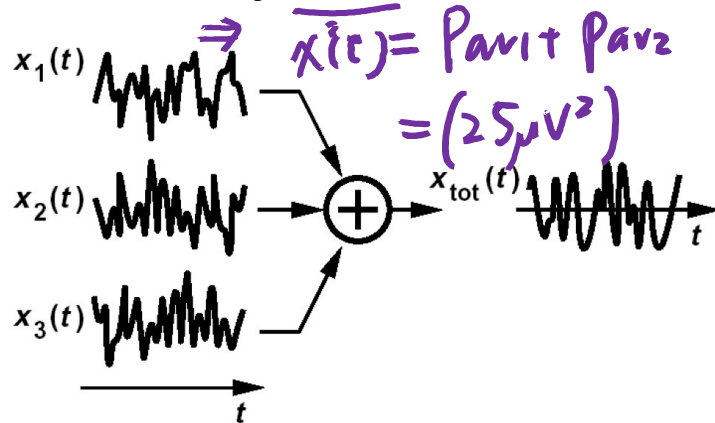
$$x(t) = x_1(t) + x_2(t) \quad = \lim_{T \rightarrow \infty} \frac{1}{T} \int (x_1^2(t) + \underline{2x_1(t)x_2(t)} + x_2^2(t)) dt$$

$$\lim_{T \rightarrow \infty} \frac{1}{T} \int_T x(t) dt = \lim_{T \rightarrow \infty} \frac{1}{T} \int_T (x_1(t) + x_2(t)) dt = P_{av1} + P_{av2}$$

$$\overline{x(t)} = \overline{x_1(t)} + \overline{x_2(t)} = 0 \quad \overline{x_1^2(t)} = (3mV_{rms})^2 + \underbrace{2x_1(t)x_2(t)}_{\text{wavy} \rightarrow 0}$$

$$\overline{x_2^2(t)} = (4mV_{rms})^2 \quad \text{if } x_1(t) \text{ and } x_2(t) \text{ are independent to E.O.}$$

We occasionally encounter correlated sources:

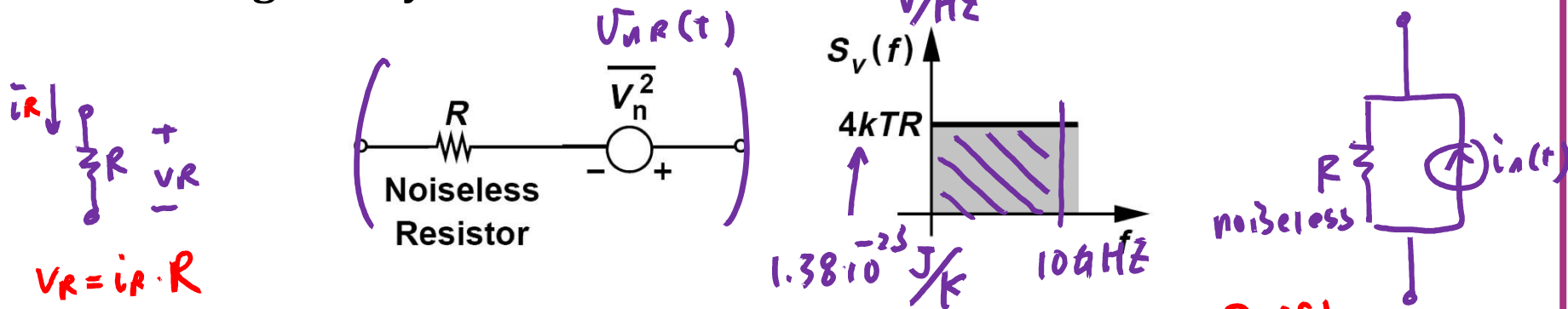


Types of Noise



1. Thermal Noise in Resistors

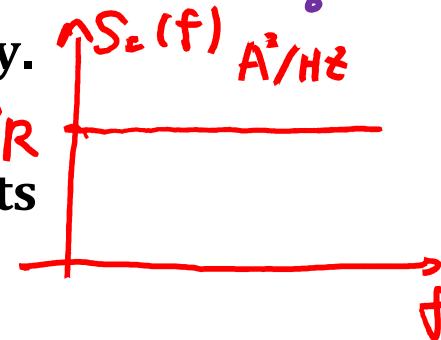
Random movement of charge carriers in a resistor causes fluctuations in the current. The PDF is Gaussian because there are so many carriers. The PSD is given by:



Note that the polarity of the voltage source is arbitrary.

Example: A $50\text{-}\Omega$ resistor at room temperature exhibits

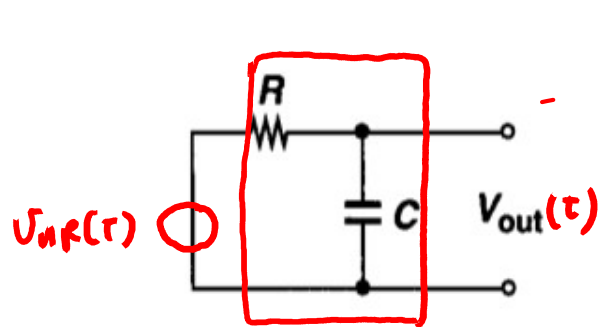
$$S_v(f) = 4 \cdot k \cdot T \cdot 50 = (91\text{ nV})^2 / \text{Hz}$$



If the resistor is used in a system with 10-GHz bandwidth, then it contributes a total rms voltage of

$$(91\text{ nV})^2 / \text{Hz} \cdot 10\text{ GHz} = (91\text{ nV}_{\text{rms}})^2$$

Example: Noise Spectrum and Total Noise Power



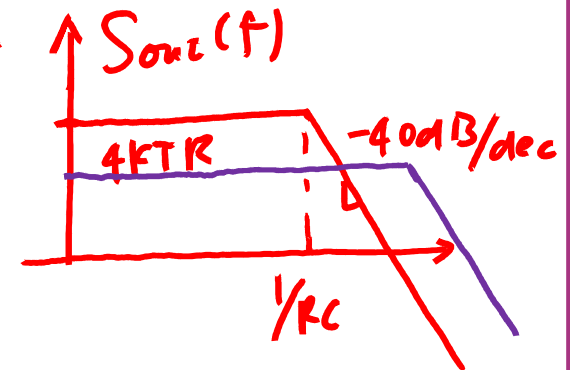
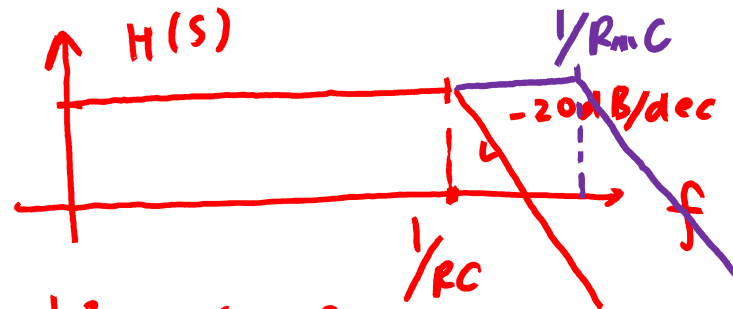
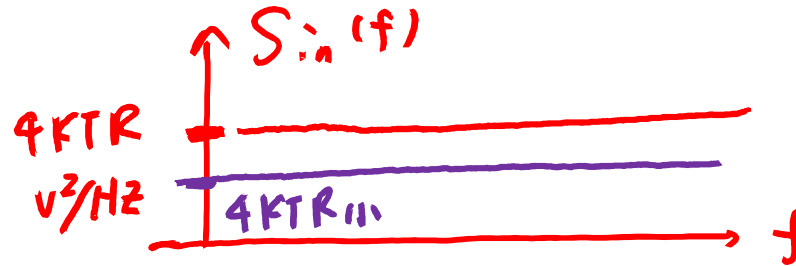
$$\frac{V_{out}}{V_R}(s) = \frac{1}{1 + sRC}$$

$$S_{out}(f) = S_{in}(f) \left| \frac{1}{1 + sRC} \right|^2 = \frac{4KTR}{1 + (\omega RC)^2}$$

$$P_{n,out} = \int S_{out}(f) df = \frac{KT}{C}$$

For $R=50 \Omega$ and $C=1 \text{ pF}$:

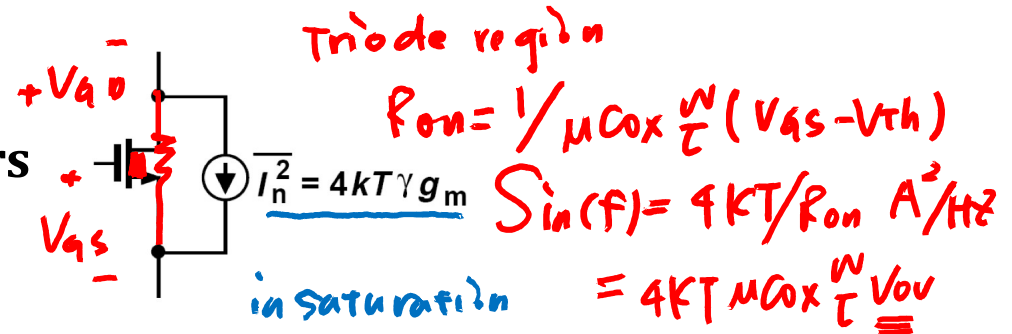
$$= (6.25 \text{ mV}_{rms})^2$$



Trade-offs between noise, area, speed, and power

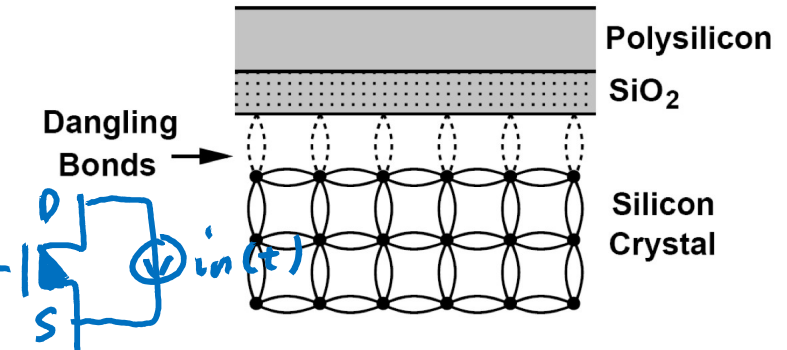
Types of Noise

2. Thermal Noise in Transistors



3. Flicker Noise in Transistors

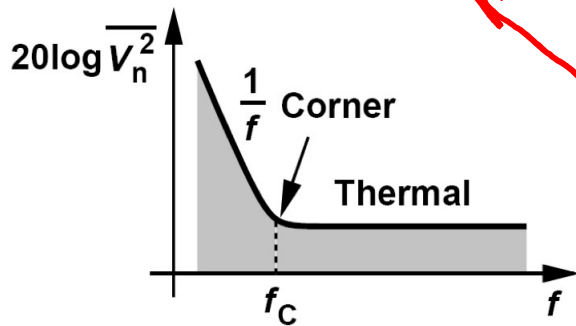
In MOSFETs, the extra energy states at the interface between silicon and oxide trap and release carriers randomly and at different rates. The noise in the drain current is Gaussian, but its spectrum is given by:



$V_n(t)$

$$S_{unf}(f) = \frac{K}{C_{ox} \cdot W \cdot L \cdot f}$$

$S_{in}(f) \propto 4kT V_{ov}$
 $= 4kT \frac{1}{\mu C_{ox} \frac{W}{L}} V_{ov} g_m$
 A^2 / Hz

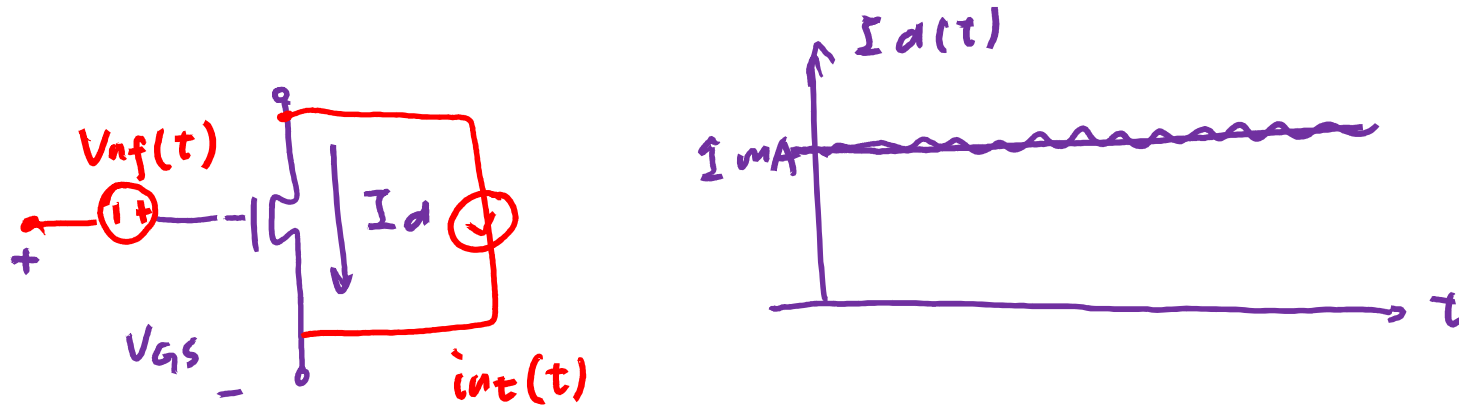


Where k is a constant and its value varies depending on how 'clean' the device is. We often characterize the noise by considering its frequency.

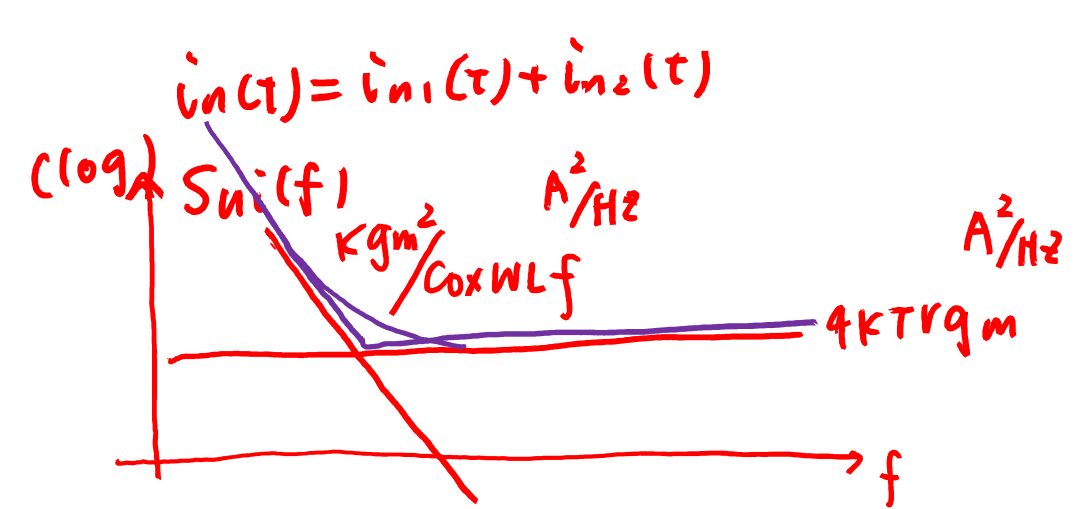
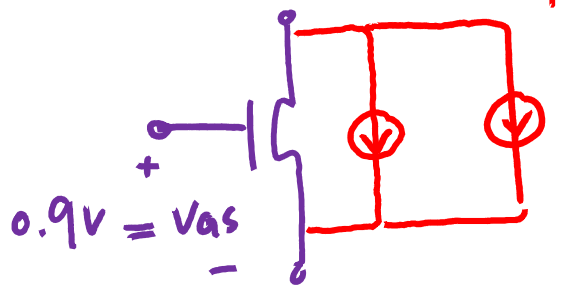
$S_{in}(f) = \frac{K g_m^2}{C_{ox} W L f} A^2 / Hz$

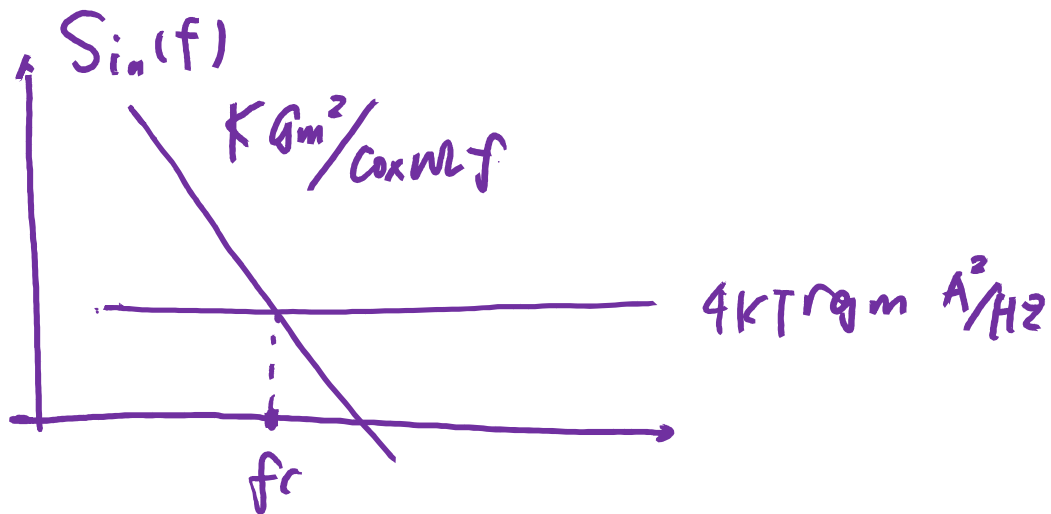
Example: A Current Source

Total noise in the drain current for a band from 1 kHz to 1 MHz



$i_{out}(t) = i_{in}(t) + i_{nf}(t)$
 $i_d(t) = 1\text{ mA} + \dot{i}_{n1}(t) + \dot{i}_{n2}(t)$





find out f_c such that $\frac{Kg_m^2}{CoxWLf_c} = 4kTrq_m$

$$f_c = \frac{K}{CoxWL} g_m \frac{1}{4kTr}$$

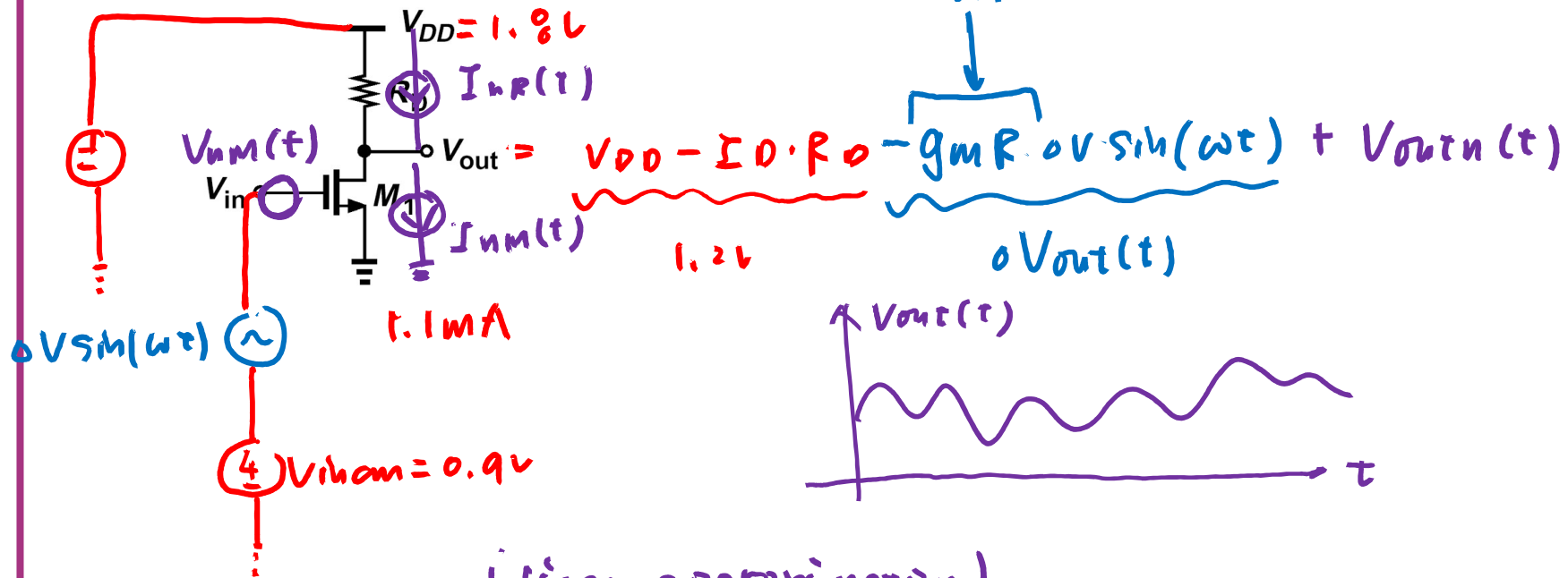
from 1kHz to 1MHz

10kHz ~ 10MHz

$$\overline{I_{n, tot}^2} = \int_{1K}^{1M} S_{in}(f) df = 4kTrq_m (10^6 - 10^3) + \frac{Kg_m^2}{CoxWL} (\ln 10^6 - \ln 10^3)$$

Common-Source Stage

$$A_v = \frac{\partial V_{out}}{\partial V_{in}}$$

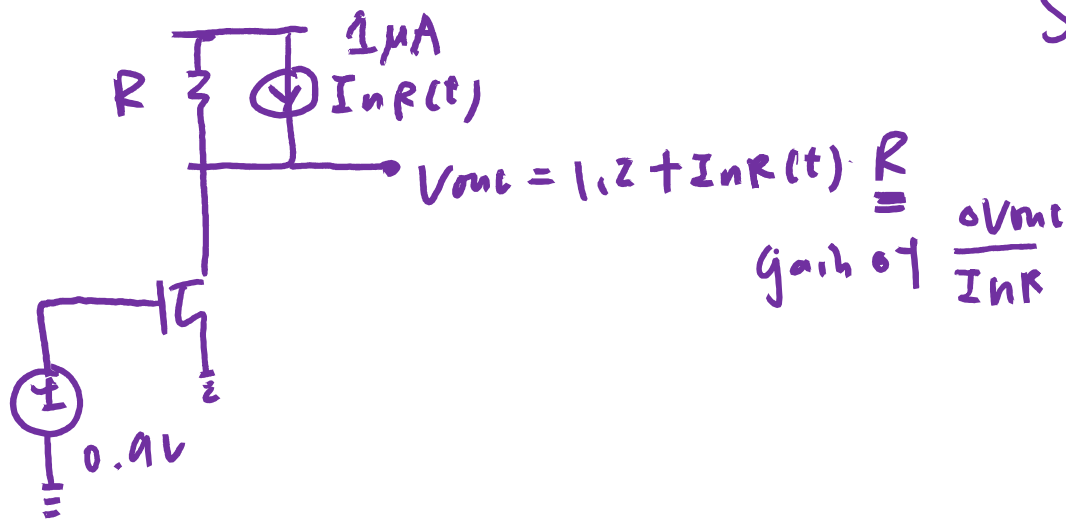
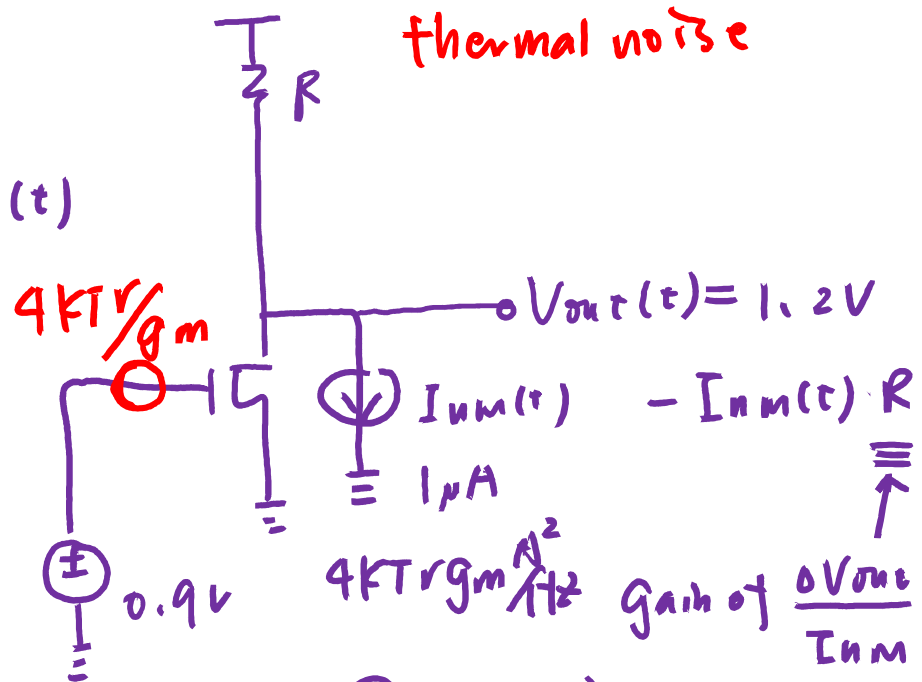
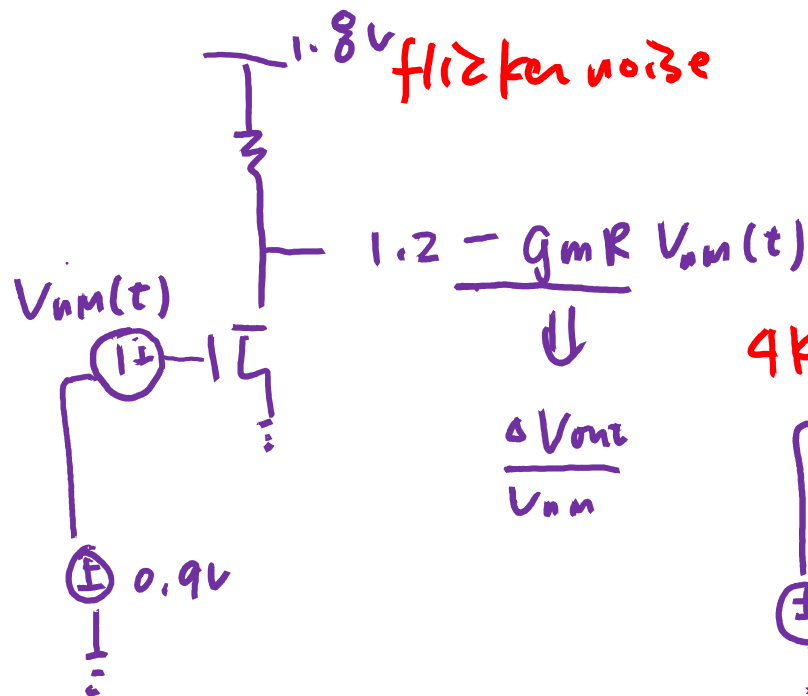


(linear approximation)

We are applying small-signal analysis with superposition for all the sources, including v_{in} , I_{NM} , I_{DP} , V_{NM} , ...

$$V_{outn}(t) = V_{NM}(t) \cdot g_m R_D - I_{DP}(t) \cdot R_D + I_{NM}(t) \cdot R_D$$

$$S_{V_{outn}}(f) = S_{V_{NM}}(f) \cdot (g_m R_D)^2 + S_{I_{DP}}(f) R_D^2 + S_{I_{NM}}(f) \cdot R_D^2$$



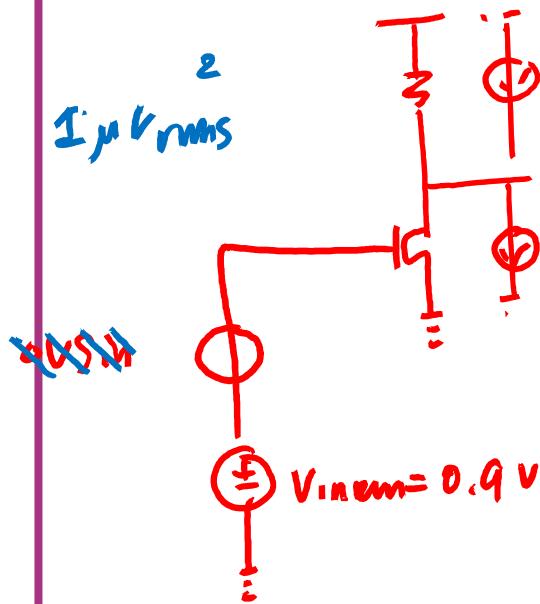
$$S_{V_{out}}(f)$$

$$= 4kTrg_m \cdot R^2$$

$$V_{outn}(t) = V_{nm}(t) \cdot g_m R$$

$$S_{V_{out}}(f) =$$

$$4kTr/g_m (g_m R)^2$$



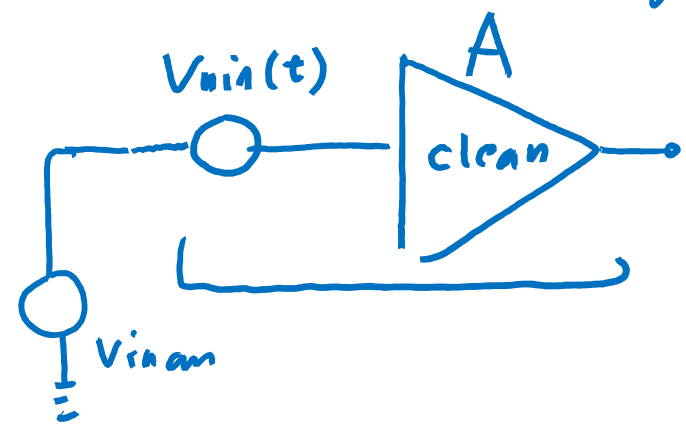
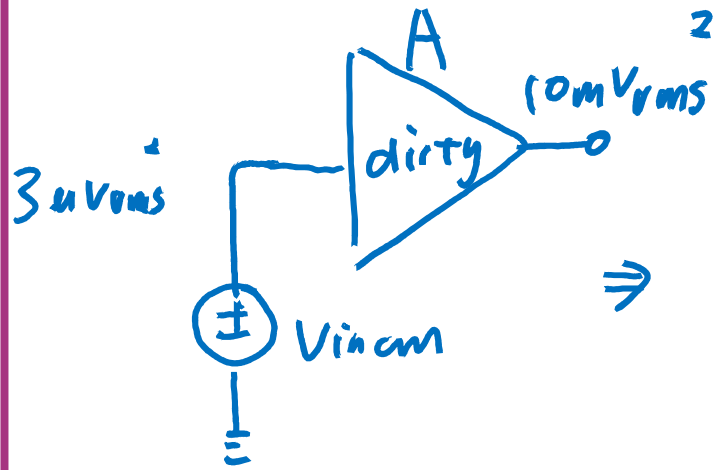
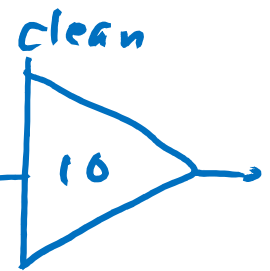
$$V_{out}(t) = 1.2 - g_m R_D V_{in}(t) + V_{noise}(t)$$

for noise

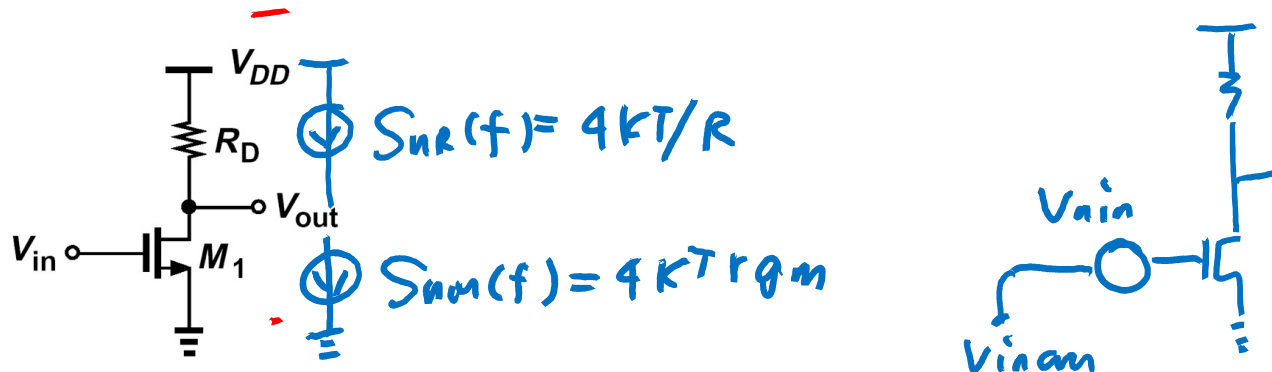
$$S_{V_{out}}(f) = S_{I_{nm}}(f) \cdot R^2 + S_{nR}(f) \cdot R^2$$

$$= 4kT r_{gm} R^2 + 4kT / R \cdot R^2 \cdot V_{in}^2 / 112$$

$5mV_{rms}^2$

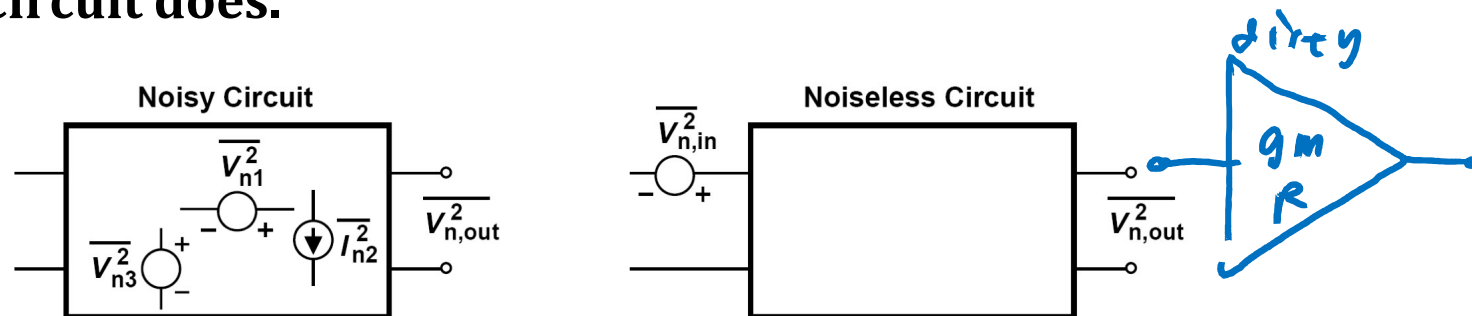


Common-Source Stage



$$\overline{V_{n,out}^2}(f) = 4kT \cdot R + 4kT r_{gm} R^2$$

Input-Referred Noise is the noise voltage or current that, when applied to the input of the noiseless circuit, generates the same output noise as the actual circuit does.



$$\overline{V_{n,in}^2}(f) = \frac{4kTR}{(g_m R)^2} + \frac{4kT r}{g_m}$$